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**IGBT** 

## SGL160N60UF

## **Ultra-Fast IGBT**

## **General Description**

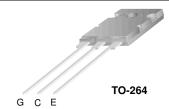
Fairchild's UF series of Insulated Gate Bipolar Transistors (IGBTs) provides low conduction and switching losses. The UF series is designed for applications such as motor control and general inverters where high speed switching is a required feature.

## **Features**

- · High speed switching
- Low saturation voltage: V<sub>CE</sub>(sat) = 2.1 V @ I<sub>C</sub> = 80A
- · High input impedance

## **Applications**

AC & DC motor controls, general purpose inverters, robotics, servo controls, and power supplies.





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Description		SGL160N60UF	Units
V <sub>CES</sub>	Collector-Emitter Voltage		600	V
V <sub>GES</sub>	Gate-Emitter Voltage		± 20	V
_	Collector Current	@ $T_C = 25^{\circ}C$	160	Α
IC	Collector Current	@ T <sub>C</sub> = 100°C	80	Α
I <sub>CM (1)</sub>	Pulsed Collector Current		300	Α
P <sub>D</sub>	Maximum Power Dissipation	@ $T_C = 25^{\circ}C$	250	W
	Maximum Power Dissipation	@ T <sub>C</sub> = 100°C	100	W
TJ	Operating Junction Temperature		-55 to +150	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

#### Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

## **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		25	°C/W

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600			V
$\Delta B_{VCES}/$ $\Delta T_J$	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0V$ , $I_C = 1mA$		0.6		V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
$I_{GES}$	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Cha	racteristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C = 80 \text{mA}, V_{CE} = V_{GE}$	3.5	4.5	6.5	V
	Collector to Emitter	I <sub>C</sub> = 80A, V <sub>GE</sub> = 15V		2.1	2.6	V
V <sub>CE(sat)</sub>	Saturation Voltage	I <sub>C</sub> = 160A, V <sub>GE</sub> = 15V		2.6		V
Dvnami	c Characteristics					
C <sub>ies</sub>	Input Capacitance		T	5000		pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 30V_{,} V_{GE} = 0V_{,}$		600		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz		200		pF
d(on)	ng Characteristics Turn-On Delay Time					
t <sub>r</sub>	Taill On Boldy Tillo			40		ne
	Rise Time			40 101		ns ns
-	Rise Time Turn-Off Delay Time	Voc = 300 V Io = 804		101		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>CC</sub> = 300 V, I <sub>C</sub> = 80A, R <sub>O</sub> = 3.90 V <sub>OC</sub> =15V		101 90	 130	ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-Off Delay Time Fall Time	$R_G = 3.9\Omega, V_{GE} = 15V$		101 90 75		ns ns ns
t <sub>d(off)</sub> t <sub>f</sub> E <sub>on</sub>	Turn-Off Delay Time Fall Time Turn-On Switching Loss			101 90	130 150	ns ns
$t_{d(off)}$ $t_{f}$ $E_{on}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss	$R_G = 3.9\Omega, V_{GE} = 15V$		101 90 75 2500	130 150	ns ns ns uJ
t <sub>d(off)</sub> t <sub>f</sub> E <sub>on</sub> E <sub>off</sub> E <sub>ts</sub>	Turn-Off Delay Time Fall Time Turn-On Switching Loss	$R_G = 3.9\Omega, V_{GE} = 15V$	  	101 90 75 2500 1760	130 150 	ns ns ns uJ
$t_{d(off)}$ $t_{f}$ $E_{on}$ $E_{off}$ $E_{ts}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss	$R_G = 3.9\Omega, V_{GE} = 15V$	   	101 90 75 2500 1760 4260	130 150   5000	ns ns ns uJ uJ
$t_{d(off)}$ $t_{f}$ $E_{on}$ $E_{off}$ $E_{ts}$ $t_{d(on)}$ $t_{r}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time	$R_G = 3.9\Omega$ , $V_{GE}=15V$ Inductive Load, $T_C = 25$ °C	    	101 90 75 2500 1760 4260 45	130 150   5000	ns ns ns uJ uJ uJ
$t_{d(off)}$ $t_{f}$ $E_{on}$ $E_{off}$ $E_{ts}$ $t_{d(on)}$ $t_{r}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time	$R_G = 3.9\Omega$ , $V_{GE} = 15V$ Inductive Load, $T_C = 25^{\circ}C$ $V_{CC} = 300 \text{ V}$ , $I_C = 80\text{ A}$ ,	     	101 90 75 2500 1760 4260 45 105	 130 150   5000	ns ns ns uJ LU uJ ns
td(off)  tf Eon Eoff Ets td(on) tr td(off)	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time	$R_G = 3.9\Omega$ , $V_{GE}=15V$ Inductive Load, $T_C = 25$ °C	      	101 90 75 2500 1760 4260 45 105	130 150   5000  200	ns ns ns uJ uJ uJ ns ns
td(off)  tf Eon Eoff Ets td(on) tr td(off)	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$R_G = 3.9\Omega$ , $V_{GE} = 15V$ Inductive Load, $T_C = 25^{\circ}C$ $V_{CC} = 300 \text{ V, } I_C = 80\text{A,}$ $R_G = 3.9\Omega$ , $V_{GE} = 15V$	     	101 90 75 2500 1760 4260 45 105 140	 130 150   5000  200 250	ns ns ns uJ uJ uJ ns ns
td(off)  tf Eon Eoff Ets td(on) tr td(off) tf Ets Ets Ets Ets Etd(on) Etr Etd(off) Etr Etd(off) Eff Eon Eoff	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss	$R_G = 3.9\Omega$ , $V_{GE} = 15V$ Inductive Load, $T_C = 25^{\circ}C$ $V_{CC} = 300 \text{ V, } I_C = 80\text{A,}$ $R_G = 3.9\Omega$ , $V_{GE} = 15V$		101 90 75 2500 1760 4260 45 105 140 122 2785	 130 150   5000  200 250	ns ns ns uJ uJ ns ns ns
td(off)  tf Eon Eoff Ets td(on) tr tr td(off) tf Eoff Eoff Eon Eoff Eoff Eon	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-On Switching Loss Turn-Off Switching Loss	$\begin{aligned} &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=25^{\circ}C \end{aligned}$ $\begin{aligned} &V_{CC}=300\text{V},I_C=80\text{A},\\ &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=125^{\circ}C \end{aligned}$		101 90 75 2500 1760 4260 45 105 140 122 2785 3100	130 150  5000  200 250	ns ns ns uJ uJ ns ns ns ns us ns ns ns ns
$\begin{array}{l} t_{d(off)} \\ t_{f} \\ E_{on} \\ E_{off} \\ E_{ts} \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ E_{on} \\ E_{off} \\ E_{ts} \\ Q_{g} \end{array}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss	$\begin{aligned} &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=25^{\circ}C \end{aligned}$ $\begin{aligned} &V_{CC}=300\text{V},I_C=80\text{A},\\ &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=125^{\circ}C \end{aligned}$ $\begin{aligned} &V_{CE}=300\text{V},I_C=80\text{A},\end{aligned}$		101 90 75 2500 1760 4260 45 105 140 122 2785 3100 5885	 130 150  5000  200 250 	ns ns ns uJ uJ us ns ns ns ns ns us
$t_{d(off)}$ $t_{f}$ $E_{on}$ $E_{off}$ $E_{ts}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Total Gate Charge	$\begin{aligned} &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=25^{\circ}C \end{aligned}$ $\begin{aligned} &V_{CC}=300\text{V},I_C=80\text{A},\\ &R_G=3.9\Omega,V_{GE}=15V\\ &\text{Inductive Load,}T_C=125^{\circ}C \end{aligned}$		101 90 75 2500 1760 4260 45 105 140 122 2785 3100 5885 345	 130 150  5000  200 250   520	ns ns ns uJ uJ ns ns ns uJ uJ ns ns ns

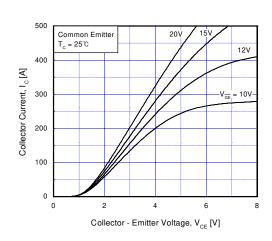
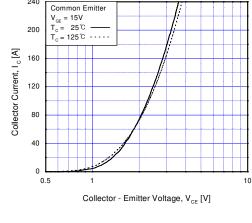


Fig 1. Typical Output Characteristics



240

Fig 2. Typical Saturation Voltage Characteristics

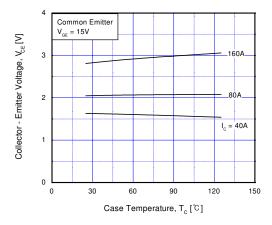


Fig 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

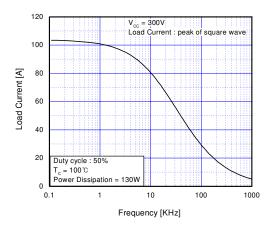


Fig 4. Load Current vs. Frequency

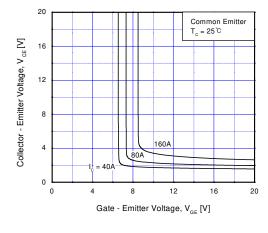


Fig 6. Saturation Voltage vs.  $V_{\text{GE}}$ 

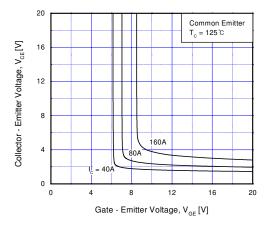
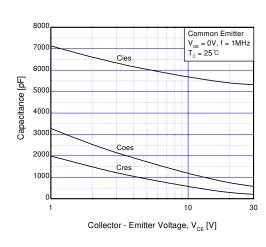


Fig 7. Saturation Voltage vs.  $V_{GE}$ 

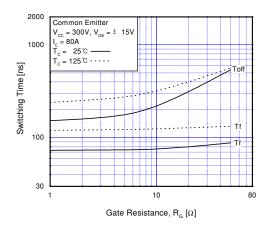
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Common Emitter  $V_{CC} = 300V, V_{GE} = \pm 15V$   $I_{C} = 80A$   $T_{C} = 25 \, \text{C} \dots$  Ton  $T_{C} = 125 \, \text{C} \dots$  To  $T_{C} =$ 

Fig 7. Capacitance Characteristics

Fig 8. Turn-On Characteristics vs.
Gate Resistance



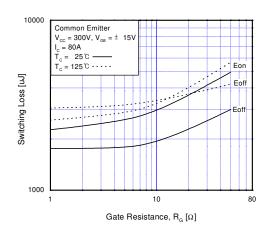
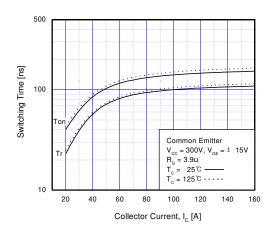


Fig 9. Turn-Off Characteristics vs. Gate Resistance

Fig 10. Switching Loss vs. Gate Resistance



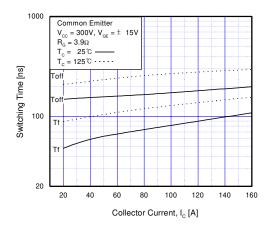
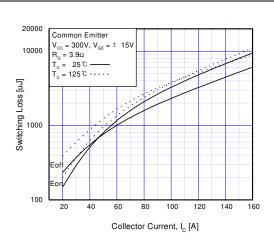


Fig 11. Turn-On Characteristics vs.
Collector Current

Fig 12. Turn-Off Characteristics vs. Collector Current



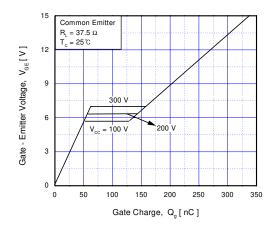
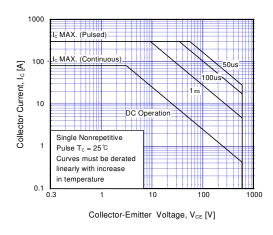


Fig 13. Switching Loss vs. Collector Current

Fig 14. Gate Charge Characteristics



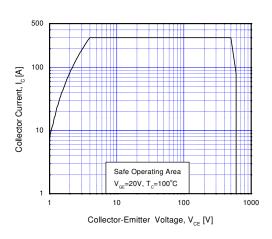


Fig 15. SOA Characteristic

Fig 16. Turn-Off SOA Characteristics

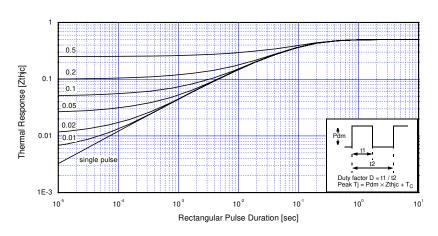
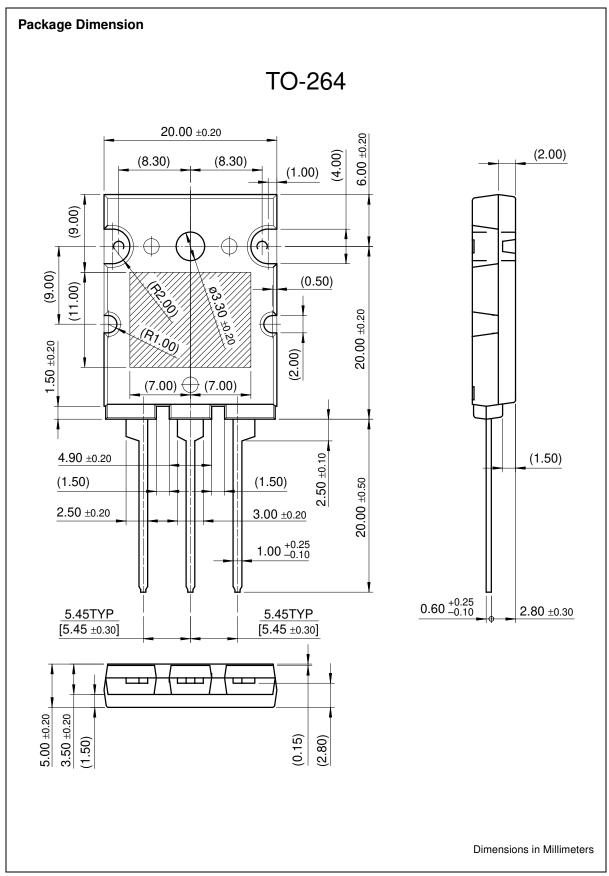


Fig 17. Transient Thermal Impedance of IGBT

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